Search Notes



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Reexamination
PEAKE ET AL.

Applicant(s)/Patent Under

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Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
375	260	2/11/2008	SP
	354		
	284		
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	262		

SEARCH NOTES

Search Notes		Date	Examiner
IEEE Xplore	0	2/11/2008	SP
East		2/11/2008	SP
Wikipedia		2/11/2008	

INTERFERENCE SEARCH

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